Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,910	CAHILL ET AL.	
Examiner	**Art Unit**	
Shin-Hon Chen	2131	

SEARCHED			
Class	Subclass	Date	Examiner
726	6,8,17	2/23/2007	S.C.
713	169,159	6/15/2007	S.C.
713	175	2/23/2007	S.C.
709	228,229	2/23/2007	S.C.
709	237	2/23/2007	S.C.
705	75,64,78	2/23/2007	S.C.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
726	**6,8,17**	2/23/2007	**S.C.**
713	169,159	6/15/2007	S.C.
713	175	2/23/2007	S.C.
705/75,64,78; 709/229,228		2/23/2007	S.C.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/15/2007	S.C.